

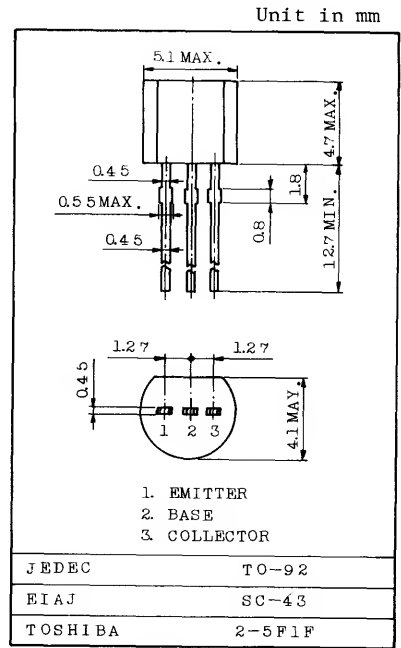
# SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

# 2N4126

FOR GENERAL PURPOSE USE SWITCHING AND AMPLIFIER APPLICATIONS.

### FEATURES:

- . Low Leakage Current
  - :  $I_{CBO} = -50\text{nA (Max.)}$  @  $V_{CB} = -20\text{V}$
  - :  $I_{EBO} = -50\text{nA (Max.)}$  @  $V_{EB} = -3\text{V}$
- . Low Saturation Voltage
  - :  $V_{CE(sat)} = -0.4\text{V (Max.)}$  @  $I_C = -50\text{mA}$ ,  $I_B = -5\text{mA}$
- . Low Collector Output Capacitance
  - :  $C_{ob} = 4.5\text{pF (Max.)}$  @  $V_{CB} = -5\text{V}$
- . Complementary to 2N4124



### MAXIMUM RATINGS ( $T_a = 25^\circ\text{C}$ )

CHARACTERISTIC	SYMBOL	RATING	UNIT
* Collector-Base Voltage	$V_{CBO}$	-25	V
* Collector-Emitter Voltage	$V_{CEO}$	-25	V
* Emitter-Base Voltage	$V_{EBO}$	-4	V
* Collector Current	$I_C$	-200	mA
Base Current	$I_B$	-50	mA
* Collector Power Dissipation ( $T_a = 25^\circ\text{C}$ ) Derate Linearly $25^\circ\text{C}$	$P_C$	350	mW
		2.8	mW/ $^\circ\text{C}$
* Collector Power Dissipation ( $T_c = 25^\circ\text{C}$ ) Derate Linearly $25^\circ\text{C}$	$P_C$	1.0	W
		8	mW/ $^\circ\text{C}$
* Thermal Resistance (Junction to Ambient)	$R_{th(j-a)}$	357	$^\circ\text{C/W}$
* Thermal Resistance (Junction to Case)	$R_{th(j-c)}$	125	$^\circ\text{C/W}$
* Junction Temperature	$T_j$	150	$^\circ\text{C}$
* Storage Temperature Range	$T_{stg}$	-55 ~ 150	$^\circ\text{C}$

\*In accordance with JEDEC registration data.

## ELECTRICAL CHARACTERISTICS (Ta=25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
* Collector Cut-off Current	$I_{CBO}$	$V_{CB}=-20V, I_E=0$	-	-	-50	nA
* Emitter Cut-off Current	$I_{EBO}$	$V_{EB}=-3V, I_C=0$	-	-	-50	nA
* Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C=-10\mu A, I_E=0$	-25	-	-	V
* Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C=-1mA, I_B=0$	-25	-	-	V
* Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E=-10\mu A, I_C=0$	-4	-	-	V
* DC Current Gain	$h_{FE(1)}$	$V_{CE}=-1V, I_C=-2mA$	120	-	360	
	$h_{FE(2)}$	$V_{CE}=-1V, I_C=-50mA$	60	-	-	
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-50mA, I_B=-5mA$	-	-	-0.4	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=-50mA, I_B=-5mA$	-	-	-0.95	V
* Small Signal Forward Current Transfer Ratio	$h_{fe}$	$V_{CE}=-20V, I_C=-10mA, f=100MHz$	2.5	-	-	
* Transition Frequency	$f_T$	$V_{CE}=-20V, I_C=-10mA, f=100MHz$	250	-	-	MHz
* Collector Output Capacitance	$C_{ob}$	$V_{CB}=-5V, I_E=0, f=1MHz$	-	-	4.5	pF
* Input Capacitance	$C_{ib}$	$V_{EB}=-0.5V, I_C=0, f=1MHz$	-	-	10	pF
* Small Signal Current Gain	$h_{fe}$	$V_{CE}=-10V, I_C=-2mA, f=1kHz$	120	-	480	
* Noise Figure	NF	$V_{CE}=-5V, I_C=-100\mu A, R_g=1k\Omega, f=10Hz \sim 15.7kHz$	-	-	4	dB

\* In accordance with JEDEC registration data.